

ISO 15625:2014-05 (E)

Silk - Electronic test method for defects and evenness of raw silk

	Contents	Page
Foreword		iv
Introduction		v
1 Scope		1
2 Normative references		1
3 Terms and definitions		1
4 Principle		2
5 Apparatus		2
6 Atmospheres for conditioning and testing		3
7 Lot formation and sampling		3
7.1 Lot formation		3
7.2 Sampling		3
8 Laboratory sample preparation		4
8.1 Raw silk in skein		4
8.2 Raw silk on cone		4
8.3 Soaked silk		4
8.4 Sampling length		4
9 Setting		4
9.1 Setting of the apparatus		4
9.2 Setting of the testing parameters of defects		5
10 Test procedure		5
11 Calculation and expression of test results		5
12 Precision		6
13 Test report		6
Annex A (normative) Defect counting and classification		7
Annex B (informative) Difference between the optical and capacitive sensors in detecting defects of raw silk		9
Annex C (normative) Method for preparing soaked raw silk in lab		10
Annex D (informative) An example of the electronic testing result sheet		12
Annex E (informative) Testing precision		13
Bibliography		15